Notice of References Cited

Application/Control No. 09/966,700	Reexamination	Applicant(s)/Patent Under Reexamination SMITH ET AL.		
Examiner	Art Unit			
Steven H.D Nguyen	2619	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0060228	03-2003	Capers et al.	455/552
*	В	US-7,260,536 B1	08-2007	Abu-Samaha, Mamoun	704/270.1
*	Ċ	US-7,130,885 B2	10-2006	Chandra et al.	709/206
*	D	US-6,938,087 B1	08-2005	Abu-Samaha, Mamoun	709/227
*	E	US-6,301,609 B1	10-2001	Aravamudan et al.	709/207
*	F	US-2002/0023131	02-2002	Wu et al.	709/205
*	G	US-2002/0013902	01-2002	Youstra, William N.	713/170
*	Н	US-7,200,634	04-2007	Mendiola et al.	709/204
*	ı	US-7,277,912	10-2007	Corboy et al.	709/203
*	J	US-2002/0086732	07-2002	Kirmse et al.	· 463/42
*	К	US-6,674,767	01-2004	Kadyk et al.	370/466
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	. 0					
	Ρ					
	Q					
	R	,				
	s		ļ			
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.